

FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. ASA-1022-03		SERIAL NO.		
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT S. HANZAWA et al				
				FILING DATE 12/04/03		GROUP 2818		
U.S. PATENT DOCUMENTS								
* EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)	
TL	AA	5,793,697	08/11/98	Scheuerlein				
TL	AB	6,314,014	11/06/01	Lowrey et al				
TL	AC	5,258,958	11/1993	Iwahashi et al				
TL	AD	5,226,014	07/1993	McManus				
TL	AE	5,410,509	04/1995	Morita				
TL	AF	5,508,960	04/1996	Pinkham				
TL	AG	4,758,995	07/1988	Sato				
	AH							
	AI							
	AJ							
	AK							
FOREIGN PATENT DOCUMENTS								
		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AL						<input type="checkbox"/>	<input type="checkbox"/>
	AM						<input type="checkbox"/>	<input type="checkbox"/>
	AN						<input type="checkbox"/>	<input type="checkbox"/>
	AO						<input type="checkbox"/>	<input type="checkbox"/>
	AP						<input type="checkbox"/>	<input type="checkbox"/>
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)								
TL	AR	Scheuerlein, R., et al, "A 10ns Read and Write Non-Volatile Memory Array Using a Magnetic Tunnel Junction and FET Switch in each Cell", IEEE						
		International Solid-State Circuits Conference, DIGEST OF TECHNICAL PAPERS, Feb 8, 2000, pp 128-131.						
TL	AS	U.S. Patent Application Publication No. US 2001/0053104,						
		Published Dec 20, 2001, Tran et al.						
	AT							
EXAMINER Thongle				DATE CONSIDERED 8/26/04				
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FORM PTO-1449
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
ASA-1022-03SERIAL NO.
10/726,658LIST OF DOCUMENTS CITED BY APPLICANT
(Use several sheets if necessary)APPLICANT
S. HANZAWA et alFILING DATE
December 4, 2003GROUP
2818

JUN 30 2004

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TL	AA 6,317,376	11/13/01	Tran et al	—	—	—
TL	AB 6,269,040	07/31/01	Reohr et al	—	—	—
	AC					
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	AI					
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	AK					

FOREIGN PATENT DOCUMENTS

	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
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